

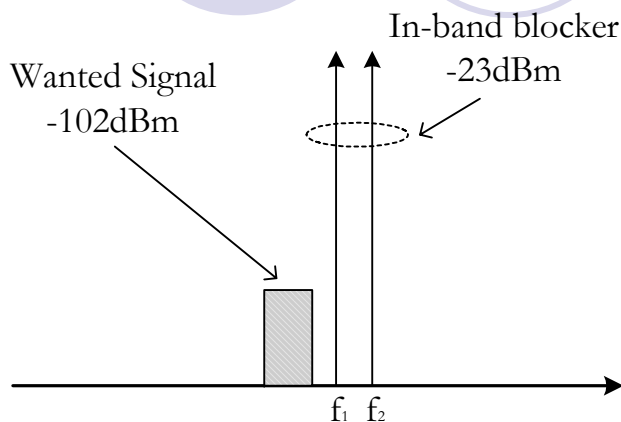


# LNA Linearization Using Bipolar Transistors

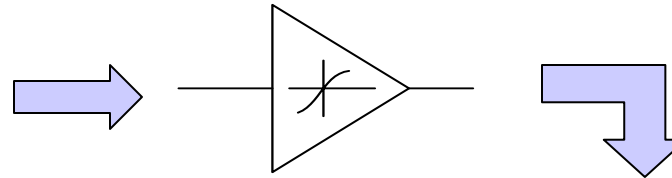
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Electrical Engineering Department  
Texas A&M University**

# Why Linearity So Important ?

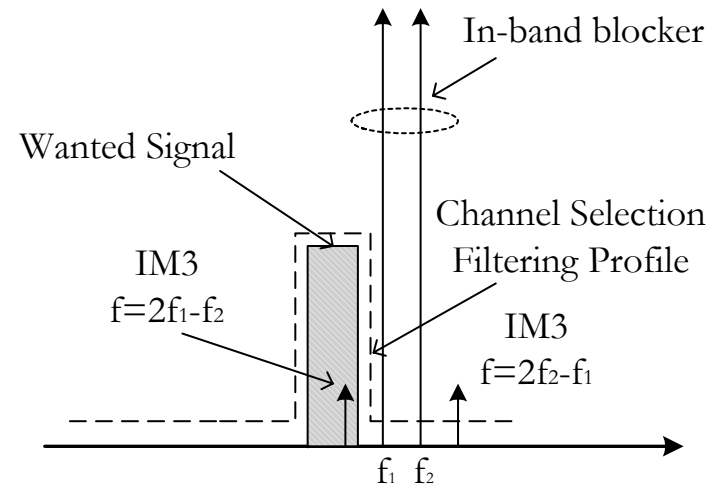


Communication system always deals with interferences.



Unwanted non-linearity will :

- Compress amplified signal
- Desensitize front-end
- Generate harmonics (filter out)
- Generate in-band interference (IMD)
- Cross-modulation



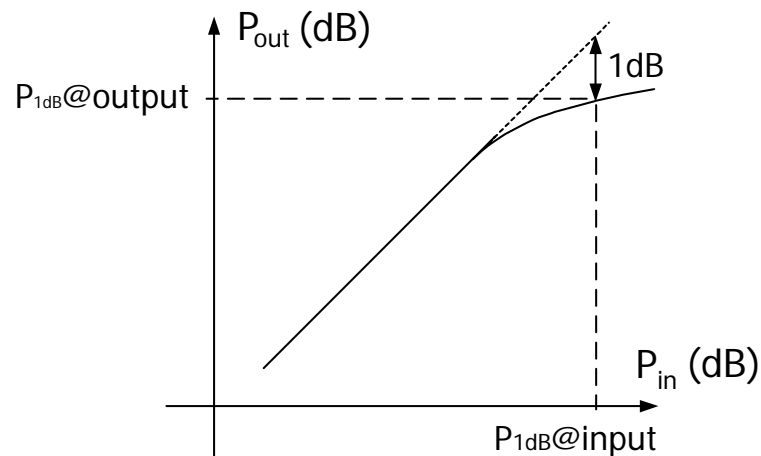
# Linearity Metrics

- 1dB compression:

Measure gain compression for large input signal

- IIP3/IIP2:

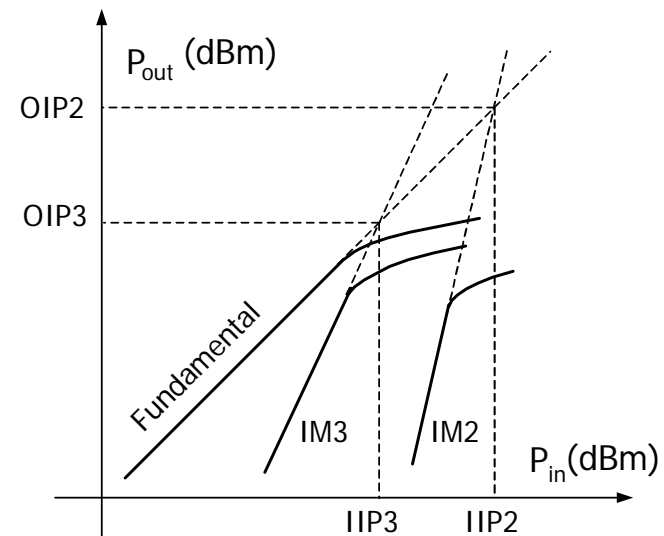
Measure inter-modulation behavior



## Relationships between IIP3 and P1dB

- For one tone test:  $IIP3 - P1dB = 10dB$

- For two tone test:  $IIP3 - P1dB = 15dB$



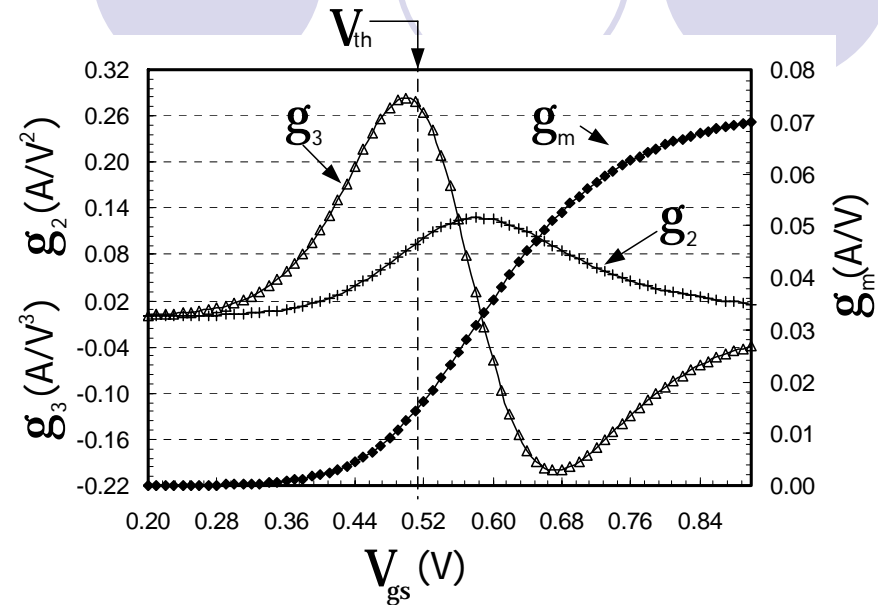
# Non-linearity Terms of MOS Device

Intrinsic MOS I-V characteristic:

$$i_{ds} = K \frac{\chi^2}{1 + \theta\chi}$$

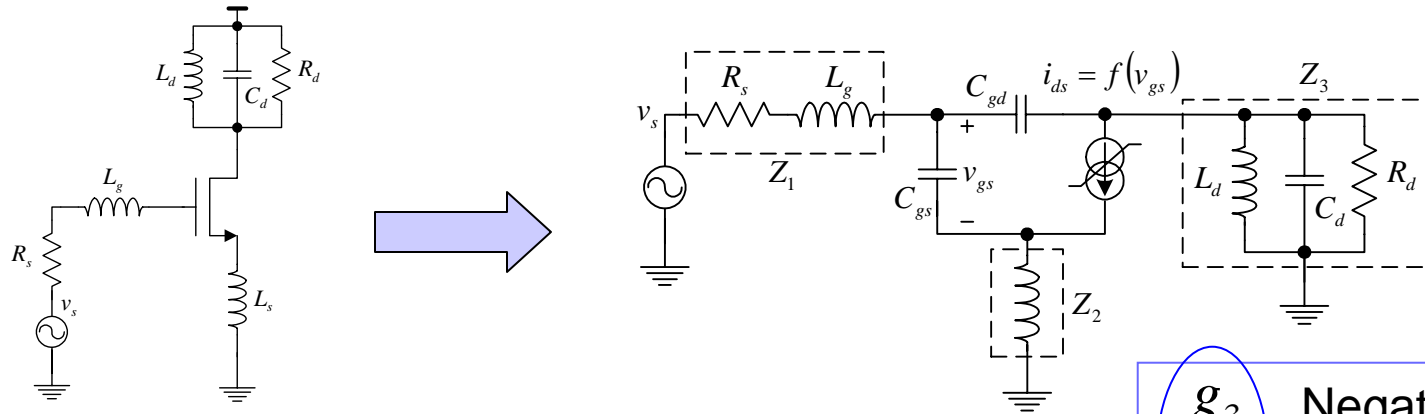
$$\chi = 2\eta\phi_t \ln\left(1 + \exp\frac{V_{gs} - V_{th}}{2\eta\phi_t}\right)$$

$$i_{ds}(v_{gs}) = g_m v_{gs} + g_2 v_{gs}^2 + g_3 v_{gs}^3$$



| Inversion Level | $g_m$  | $g_2$                             | $g_3$                                     |
|-----------------|--|-----------------------------------|---|
| Strong/moderate | $\frac{KV_{od}(2 + \theta V_{od})}{(1 + \theta V_{od})^2}$ | $\frac{K}{(1 + \theta V_{od})^3}$ | $-\frac{\theta K}{(1 + \theta V_{od})^4}$ |
| Weak            | $\frac{I_{s0}}{\eta\phi_t}$                                | $\frac{I_{s0}}{2(\eta\phi_t)^2}$  | $\frac{I_{s0}}{6(\eta\phi_t)^3}$          |

# Non-Linearity Analysis of Conventional Inductive Degenerated LNA



$$IIP3(2\omega_2 - \omega_1) = \frac{1}{6R_s \cdot |H(\omega)| \cdot |A_1(\omega)|^3 \cdot |\varepsilon(\Delta\omega, 2\omega)|}$$

$$\varepsilon(\Delta\omega, 2\omega) = g_3 - g_{oB}(\Delta\omega, 2\omega)$$

$$g_{oB}(\Delta\omega, 2\omega) = \frac{2}{3} g_2^2 \left[ \frac{2}{g_m + g(\Delta\omega)} + \frac{1}{g_m + g(2\omega)} \right]$$

$g(\cdot)$  is a function of Z1, Z2 and Z3

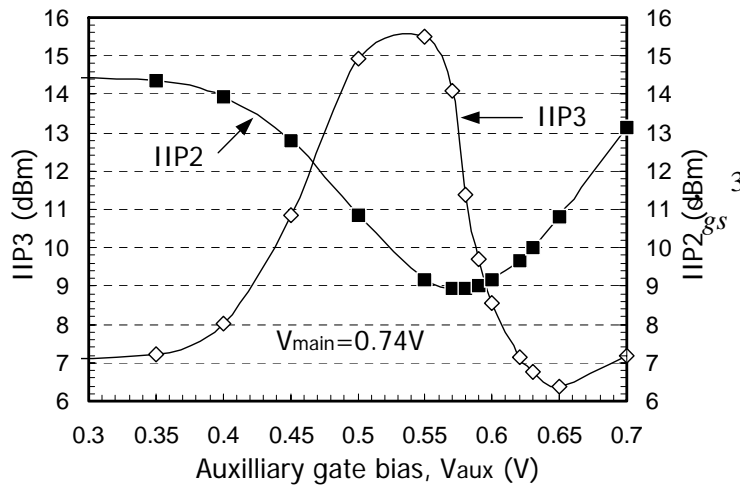
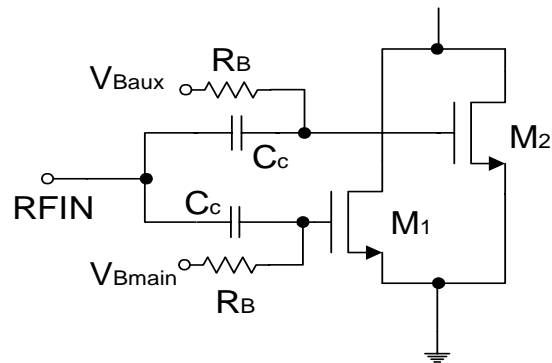
$g_3$  Negative  
 $g_{oB}$  Positive

$|g_3| \downarrow$   
 $|g_{oB}| \updownarrow \Rightarrow IIP3 \uparrow$

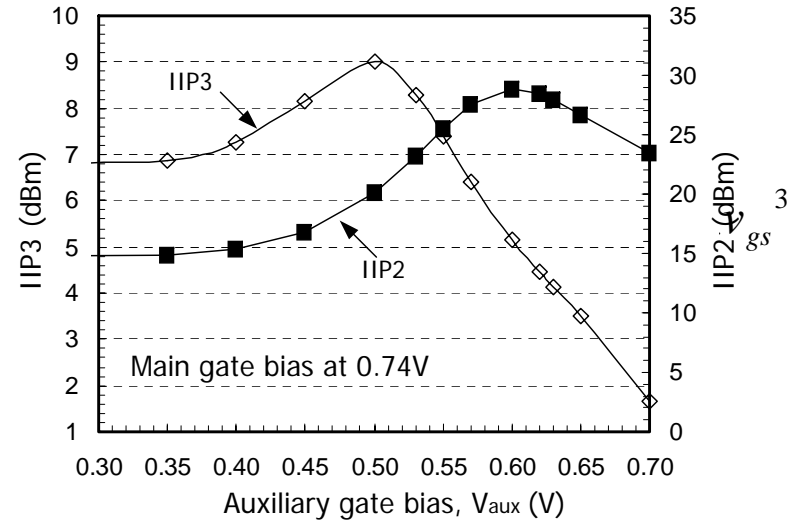
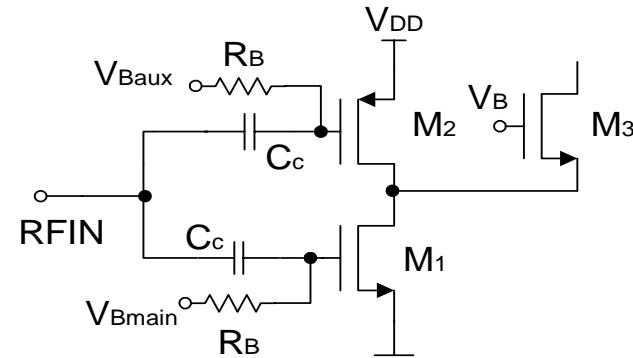
The absolute value of these two quantities should be kept small in order to achieve high linearity.

# Review of Multi-Gated-Transistor Linearization

Original Configuration:

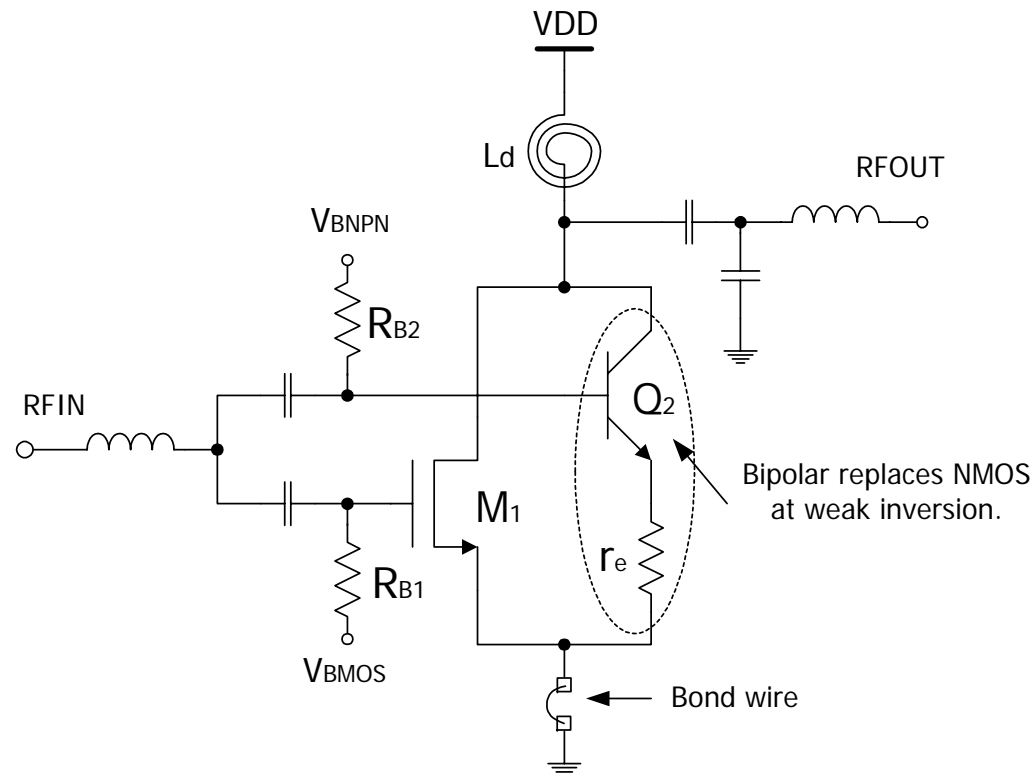


Alternate Configuration:

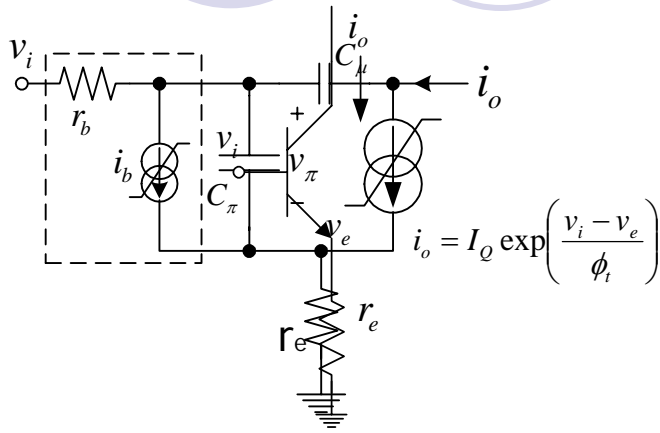


# Proposed Method: Hybrid LNA

- ❑ MOS in weak inversion has speed problem
- ❑ MOS transistor in weak inversion acts like bipolar
- ❑ Bipolar available in TSMC 0.18 technology (not a parasitic BJT)
- ❑ Why not using that bipolar transistor to improve linearity ?

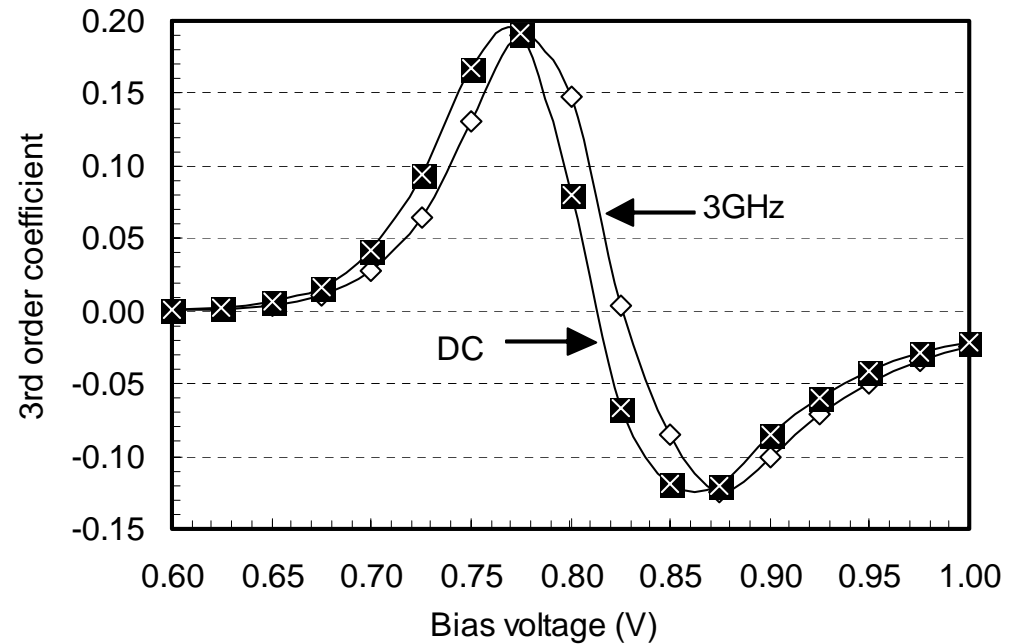


# Linearity Analysis of the BJT



$$g_{3,bjt} = \frac{1}{6I_Q^2} \frac{g_m^3}{(1 + g_m r_e)^5} (1 - 2g_m r_e)$$

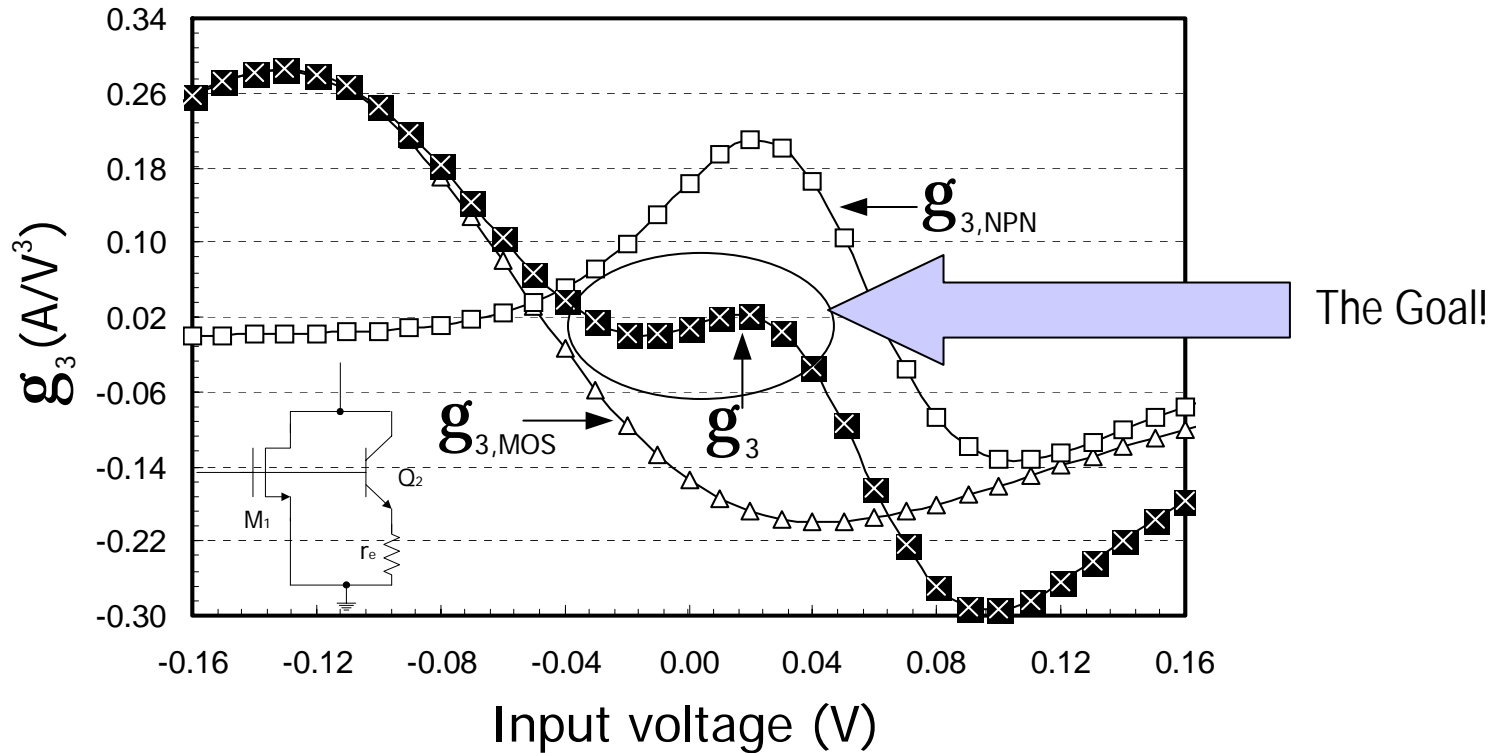
Weak memory effect



- Bipolar is more non-linear than MOS
- Degeneration used to match the 3<sup>rd</sup> order non-linear term of MOST

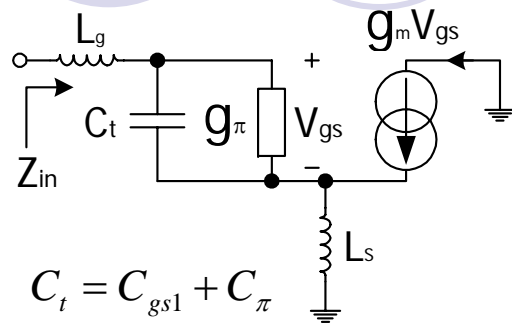


# 3<sup>rd</sup> Order Cancellation Effect



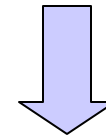
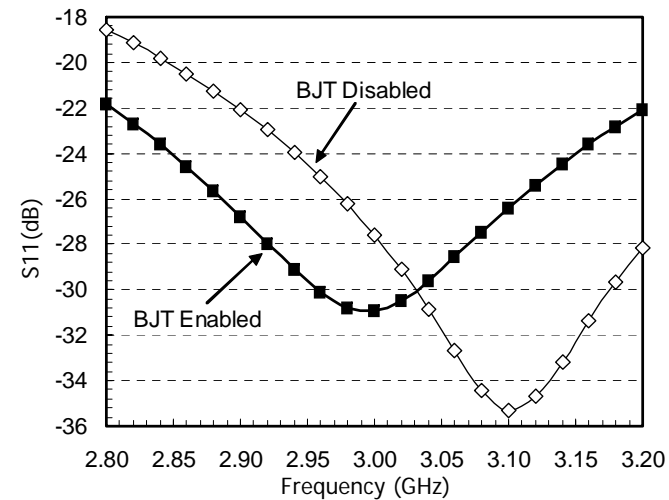
- MOS and BJT biased separately
- MOS in moderate inversion, BJT in active region

# Effects on Input Impedance Matching and Noise



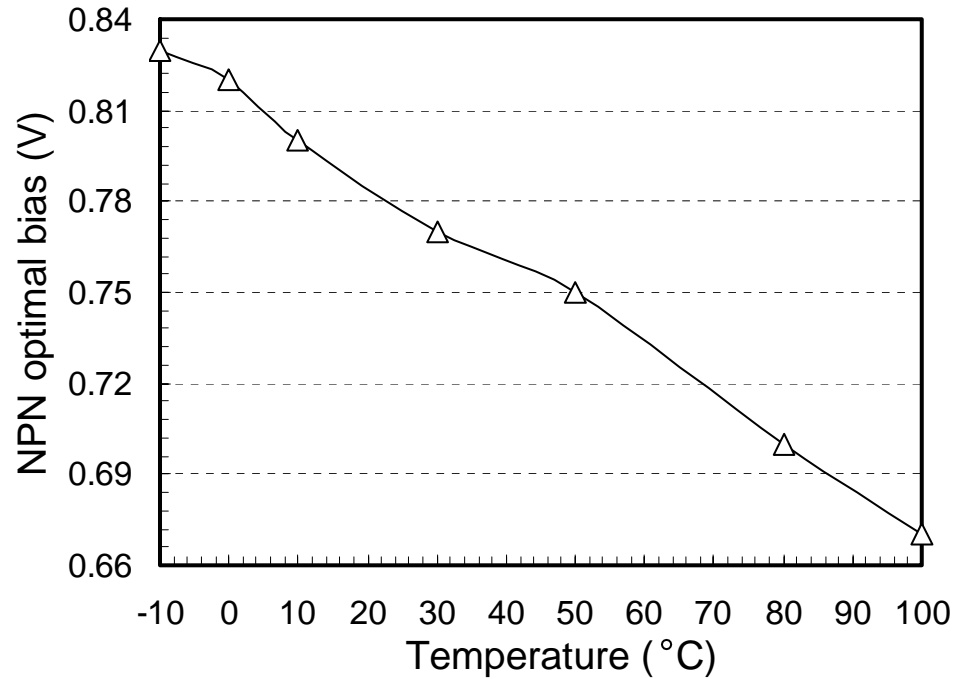
- ❑ BJT biased at low current: 320uA
- ❑ BJT noise contribution: 2.4%

| Device             | Noise ratio |
|--------------------|-------------|
| Source Resistance  | 60%         |
| MOS Transistor     | 14%         |
| Bipolar Transistor | 2.4%        |
| Other              | 23.6%       |



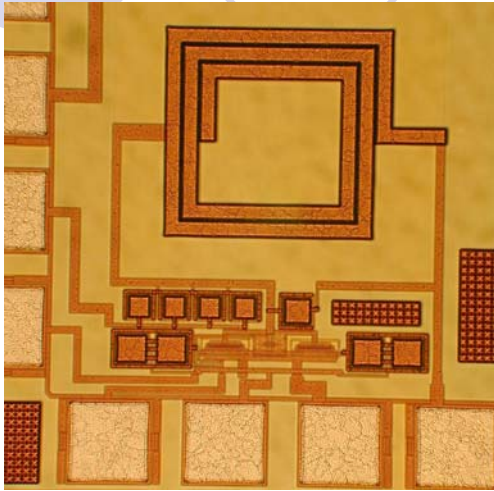
$C_{\pi}$  shifts the matching point to a lower frequency  
 $g_{\pi}$  moves the impedance away from the intended value

# Biassing Temperature Profile



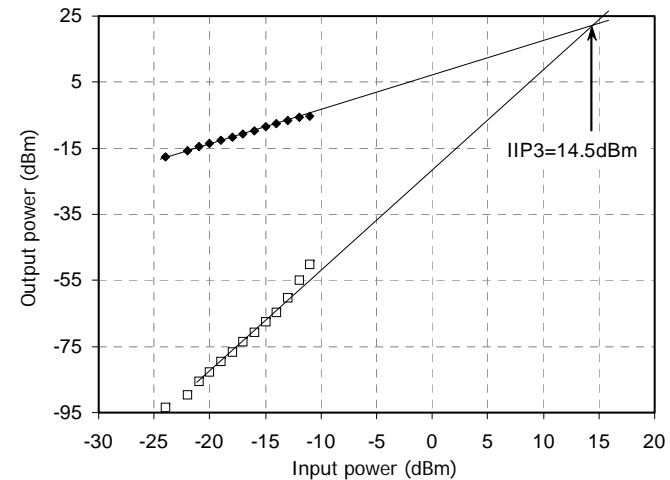
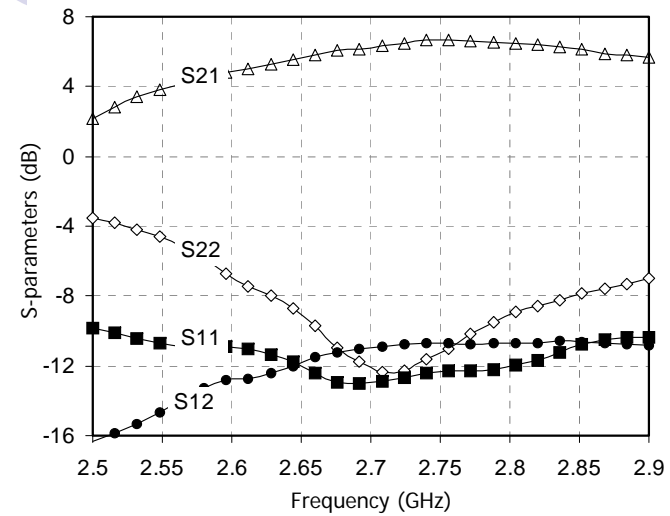
- MOS biased by constant- $g_m$
- BJT biased by a PTAT circuit

# Experimental Results of the Proposed Linearized LNA



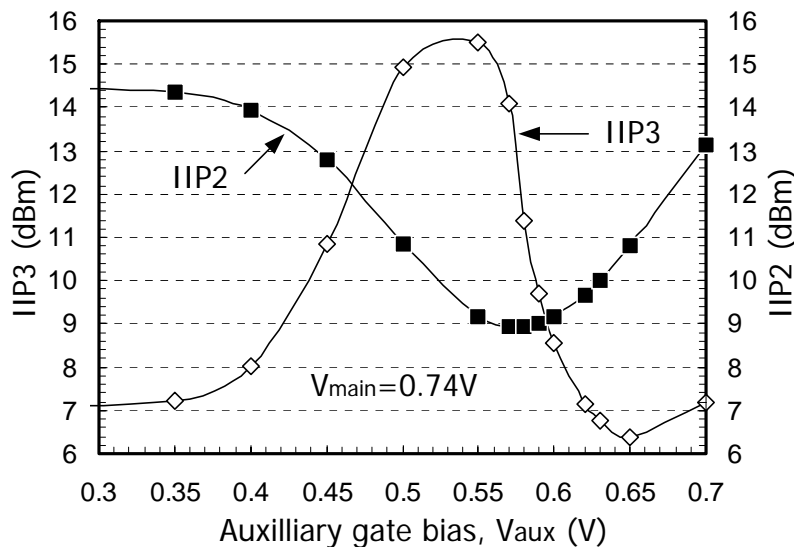
Active area: 390um x 290um

|           |      |     |
|-----------|------|-----|
| Frequency | 2.7  | GHz |
| Gain      | 6.4  | dB  |
| IIP3      | 14.5 | dBm |
| NF        | 2.1  | dB  |
| Pd        | 8.9  | mW  |



# Extend to a Differential Version

- ❑ Single-ended suffers from small IIP2
- ❑ Out-of-band termination



$$IIP3(2\omega_2 - \omega_1) = \frac{1}{6R_s \cdot |H(\omega)| \cdot |A_1(\omega)|^3 \cdot |\varepsilon(\Delta\omega, 2\omega)|}$$

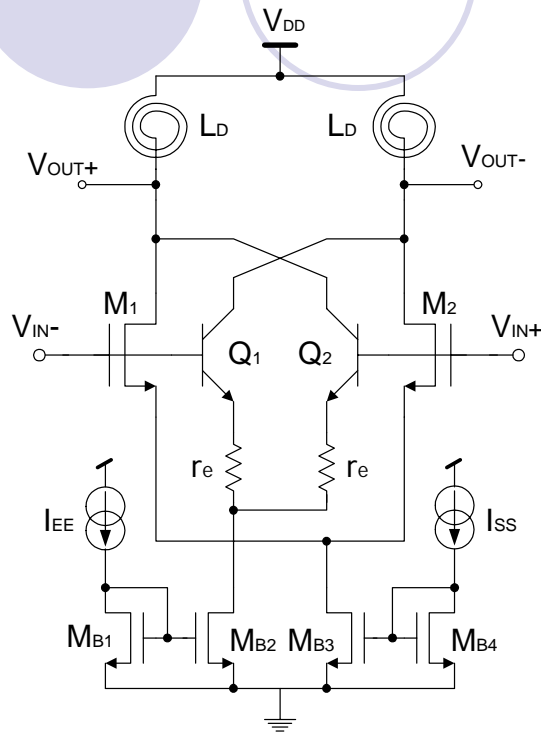
$$\varepsilon(\Delta\omega, 2\omega) = g_3 - g_{oB}(\Delta\omega, 2\omega)$$

$$g_{oB}(\Delta\omega, 2\omega) = \frac{2}{3} g_2^2 \left[ \frac{2}{g_m + g(\Delta\omega)} + \frac{1}{g_m + g(2\omega)} \right]$$

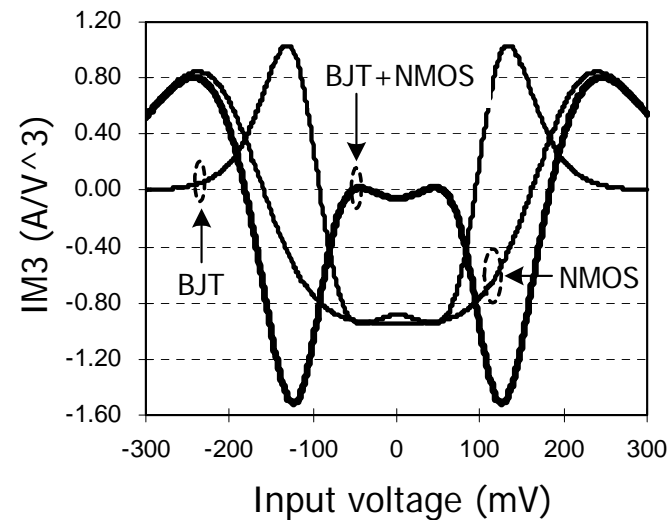
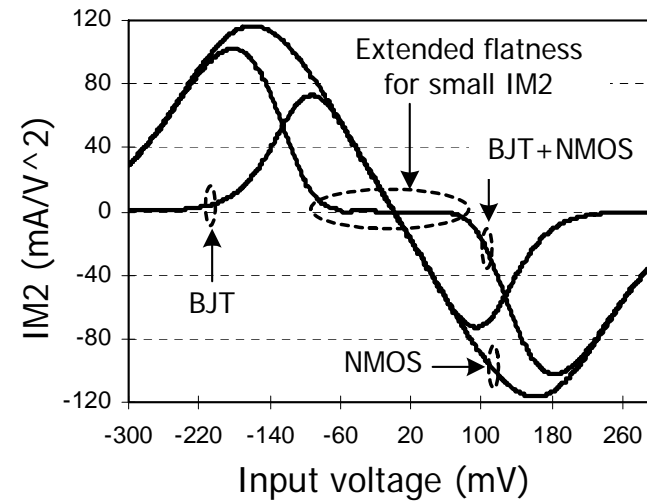
- ❑ The 3<sup>rd</sup> order term of MOS and BJT differential pair has the same sign.
- ❑ BJT is more non-linear than MOS
- ❑ Less current for BJT to present same non-linearity as MOS
- ❑ Cross-couple MOS and BJT differential pair will help

# Extend to a Differential Version

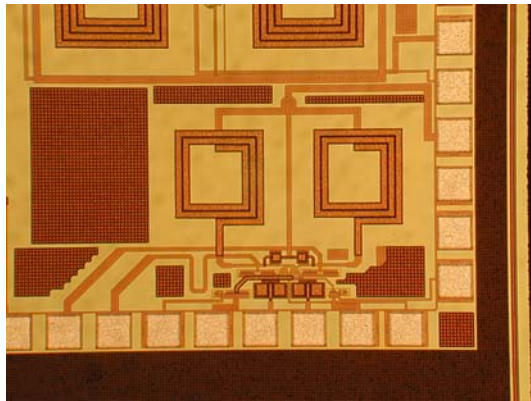
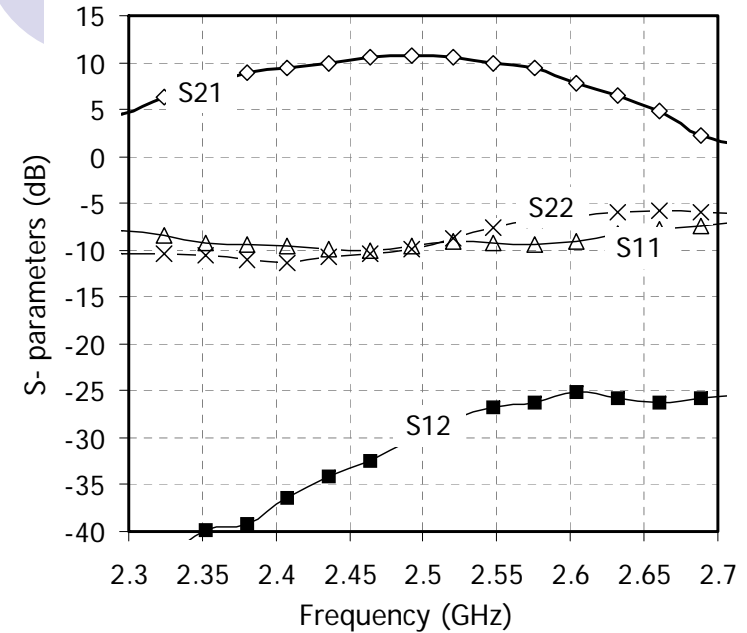
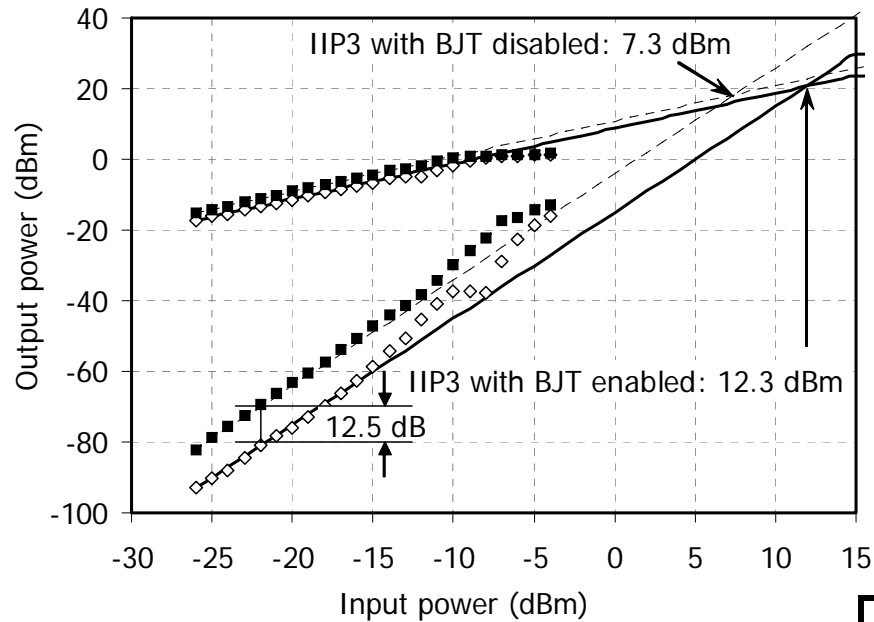
(Cont'd)



- ❑ BJT pair contributes 15% of noise
- ❑ Larger noise figure: 3.4 dB
- ❑ Larger current dissipation: 10mA
- ❑ Better reverse isolation: 25 dB
- ❑ No need out-of-band termination

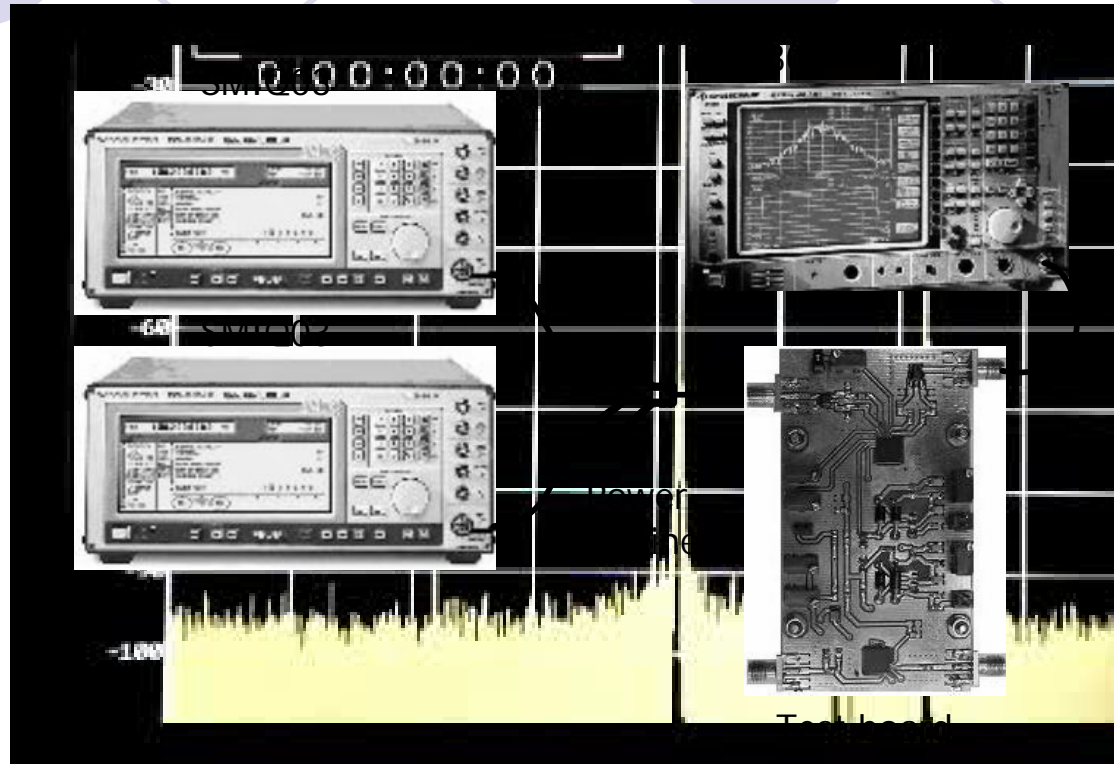


# Experimental Results of the Proposed Differential LNA



|           |      |     |
|-----------|------|-----|
| Frequency | 2.5  | GHz |
| Gain      | 10   | dB  |
| IIP3      | 12.5 | dBm |
| NF        | 3.4  | dB  |
| Pd        | 19.8 | mW  |

# IM3 Cancellation Demo



Measurement setup

Measurement video clip shows the IM3 cancellation effect of BJT differential pair in the differential LNA.



# Comparison Table

|                            | Frequency | Gain | NF   | IIP3 | Pd   | FOM  |
|----------------------------|-----------|------|------|------|------|------|
|                            | GHz       | dB   | dB   | dBm  | mW   |      |
| Single-ended<br>[1]        | 0.9       | 10   | 2.85 | 15.6 | 21.1 | 18.5 |
| Single-ended<br>[proposed] | 2.7       | 6.4  | 2.1  | 14.5 | 8.9  | 22.8 |
| Differential<br>[2]        | 0.9       | 5    | 2.8  | 18   | 45   | 4.9  |
| Differential<br>[proposed] | 2.5       | 10   | 3.4  | 12.3 | 19.8 | 7.2  |
| BiCMOS<br>[Simulated]      | 3         | 9.5  | 1.2  | 12   | 6.6  | 67   |

$$FOM = \frac{G \cdot IIP3}{(F - 1)P_D}$$

# Conclusions



- ❑ Hybrid: Bipolar linearizes MOST
- ❑ Differential structure: no degradation on IIP2
- ❑ Better trade-offs between design parameters
- ❑ Good figure of merit